

L Number	Hits	Search Text	DB	Time stamp
1	118	(250/306 or 250/307) and ((inspect\$4 or measu\$5) with (hole or via)) and	USPAT	2002/10/01 02:23
2	108	((detect\$4 or measur\$5) with current) ((250/306 or 250/307) and ((inspect\$4 or measu\$5) with (hole or via)) and ((detect\$4 or measur\$5) with current)) and scan\$6	USPAT	2002/10/01 02:26
3	1	"6037588"	USPAT	2002/10/01 02:23
4	73	((250/306 or 250/307) and ((inspect\$4 or measu\$5) with (hole or via)) and ((detect\$4 or measur\$5) with current)) and scan\$6) and display\$4	USPAT	2002/10/01 02:26

L Number	Hits	Search Text	DB	Time stamp
1	3	(method with inspect\$4 with hole) and (((charged adj particle) or charged-particle or electron) near beam) and display\$4 and ((deteact\$4 or measur\$4) adj current)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/01 14:16
8	0	((method with inspect\$4 with hole) and (((charged adj particle) or charged-particle or electron) near beam) and display\$4 and ((deteact\$4 or measur\$4) adj current)) and (current with averag\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/01 14:11
15	16	((250/307) or (250/306)) and (method with inspect\$4 with hole) and (((charged adj particle) or charged-particle or electron) near beam)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/01 14:18
22	12	((((250/307) or (250/306)) and (method with inspect\$4 with hole) and (((charged adj particle) or charged-particle or electron) near beam)) and ((detect\$4 or measur\$5) with current))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/01 14:20
29	9	((((250/307) or (250/306)) and (method with inspect\$4 with hole) and (((charged adj particle) or charged-particle or electron) near beam)) and ((detect\$4 or measur\$5) with current)) and averag\$3 and (period or time)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/01 14:21
36	2	((((250/307) or (250/306)) and (method with inspect\$4 with hole) and (((charged adj particle) or charged-particle or electron) near beam)) and ((detect\$4 or measur\$5) with current)) and (averag\$3 with current)and (period or time)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/01 14:22
43	2	(((((250/307) or (250/306)) and (method with inspect\$4 with hole) and (((charged adj particle) or charged-particle or electron) near beam)) and ((detect\$4 or measur\$5) with current)) and (averag\$3 with current)and (period or time)) and scan\$5	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/01 14:22